



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10725612</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>ASARE ET AL.</p>
	<p>Examiner</p> <p>Chen, Qing</p>	<p>Art Unit</p> <p>2191</p>

Class	SubClass	Date	Examiner
717	174	07/05/2006	QC
717	175	07/05/2006	QC

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<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10725612	ASARE ET AL.
	Examiner Chen, Qing	Art Unit 2191

Notes	Date	Examiner
EAST Search -- US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM TDB -- See Search History Printout	07/05/2006	QC
EAST Inventor Name Search and Assignee Search -- US-PGPUB; USPAT -- See Search History Printout	07/05/2006	QC
EIC Search -- See STIC Search Results Printout	07/05/2006	QC
PLUS Search	06/29/2006	QC
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